GSM4535

40V P-Channel Enhancement Mode MOSFET

Product Description

GSM4535, P-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent $R_{DS(ON)}$, low gate charge.
These devices are particularly suited for low voltage power management, and low in-line power loss are needed in commercial industrial surface mount applications.

Features

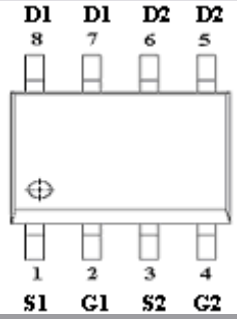
- -40V/-6.2A,$R_{DS(ON)}$= 35mΩ@V_{GS}= -10V
- -40V/-5.2A,$R_{DS(ON)}$= 50mΩ@V_{GS}= -4.5V
- Super high density cell design for extremely low $R_{DS\ (ON)}$
- SOP-8P package design

Applications

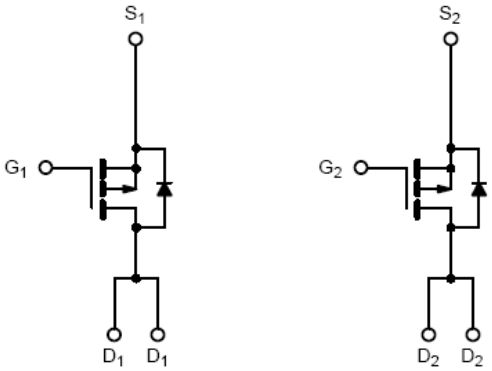
- Backlight Inverter for LCD Display
- Full Bridge DC/DC Converter
- Load Switch
- CCFL Inverter

Packages & Pin Assignments

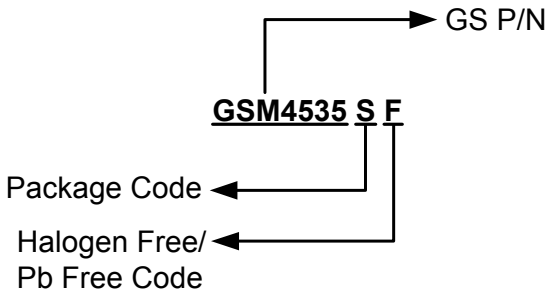
GSM4535SF(SOP-8)



1	Source1	5	Drain2
2	Gate1	6	Drain2
3	Source2	7	Drain1
4	Gate2	8	Drain1

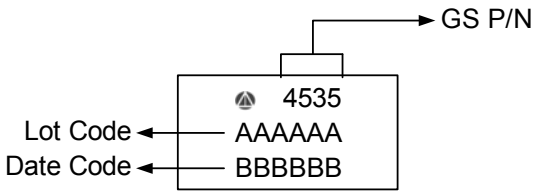


Ordering Information



Part Number	Package	Quantity Reel
GSM4535SF	SOP-8	3000 PCS

Marking Information



Absolute Maximum Ratings

(T_A=25ºC unless otherwise noted)

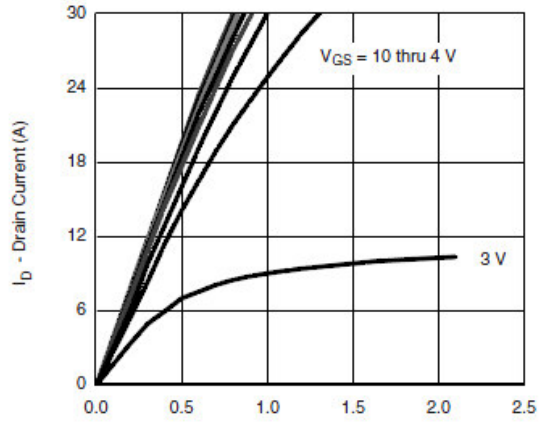
Symbol	Parameter		Typical	Unit
V_{DSS}	Drain-Source Voltage		-40	V
V_{GSS}	Gate –Source Voltage		±20	V
I_D	Continuous Drain Current(T_J=150ºC)	T_A=25ºC	-6.2	A
		T_A=70ºC	-5.2	
I_{DM}	Pulsed Drain Current		-20	A
I_S	Continuous Source Current(Diode Conduction)		-1.7	A
P_D	Power Dissipation	T_A=25ºC	2.8	W
		T_A=70ºC	1.8	
T_J	Operating Junction Temperature		150	ºC
T_{STG}	Storage Temperature Range		-55/150	ºC
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient		62.5	ºC/ W

Electrical Characteristics

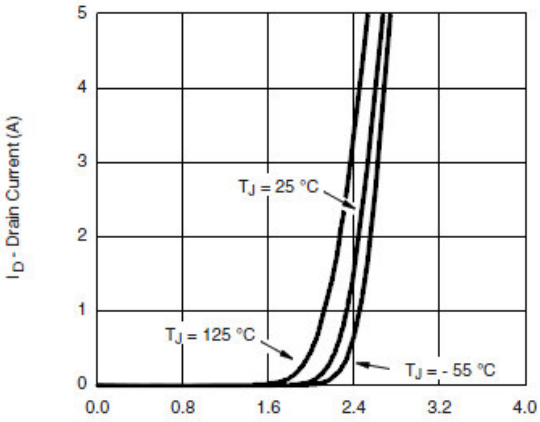
(T_A=25ºC unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ	Max.	Unit
Static						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V_{GS}=0V,I_D=-250uA	-40			V
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS},I_D=-250uA	-1.0		-3.0	
I_{GSS}	Gate Leakage Current	V_{DS}=0V,V_{GS}=±20V			±100	nA
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=-40V,V_{GS}=0V			-1	uA
		V_{DS}=-40V, V_{GS}=0V,T_J=85ºC			-20	
$I_{D(on)}$	On-State Drain Current	V_{DS} ≤ -5V,V_{GS}=-10V	-20			A
$R_{DS(on)}$	Drain-Source On-Resistance	V_{GS}=-10V,I_D=-6.2A		30	35	mΩ
		V_{GS}=-4.5V,I_D=-5.2A		44	50	
g_{fs}	Forward Transconductance	V_{DS}=-15V,I_D=-5A		20		S
V_{SD}	Diode Forward Voltage	I_S=-2A,V_{GS}=0V		-0.8	-1.2	V
Dynamic						
C_{iss}	Input Capacitance	V_{DS}=-20V, V_{GS}=0V,f=1MHz		1100		pF
C_{oss}	Output Capacitance			145		
C_{rss}	Reverse Transfer Capacitance			115		
Q_g	Total Gate Charge	V_{DS}=-20V, V_{GS}=-4.5V,I_D≡-5.0A		13	20	nC
Q_{gs}	Gate-Source Charge			4.5		
Q_{gd}	Gate-Drain Charge			6.5		
$t_{d(on)}$	Turn-On Time	V_{DD}=-20V, R_L=4Ω ,I_D≡-5.0A V_{GEN}=-4.5V,R_G=1Ω		40	80	ns
T_r				55	100	
$t_{d(off)}$	Turn-Off Time			30	60	
T_f				12	20	

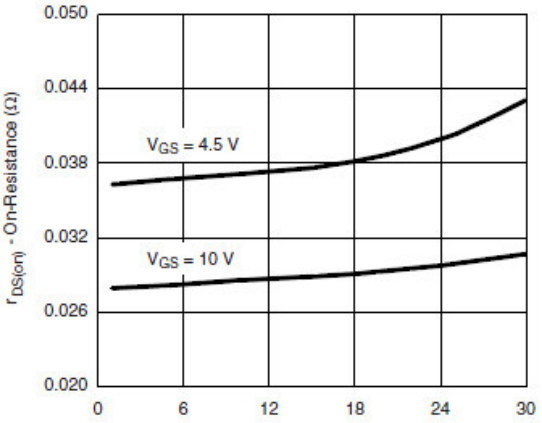
Typical Performance Characteristics



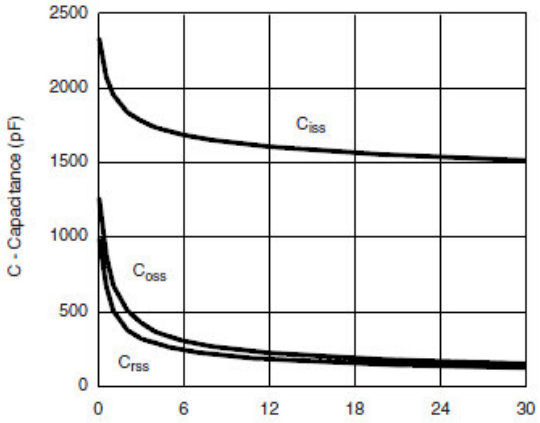
Output Characteristics



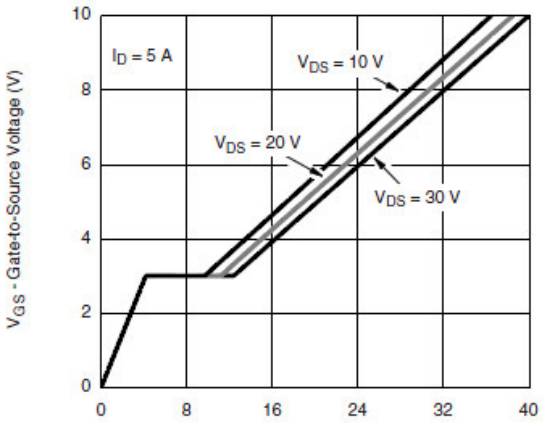
Transfer Characteristics



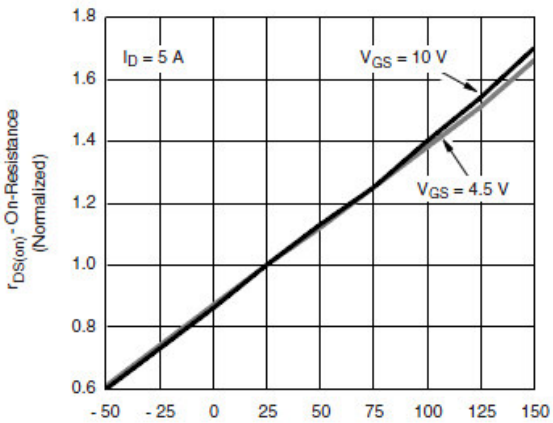
On-Resistance vs. Drain Current



Capacitance

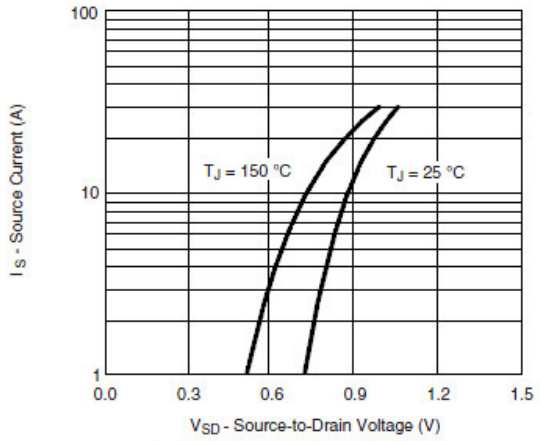


Gate Charge

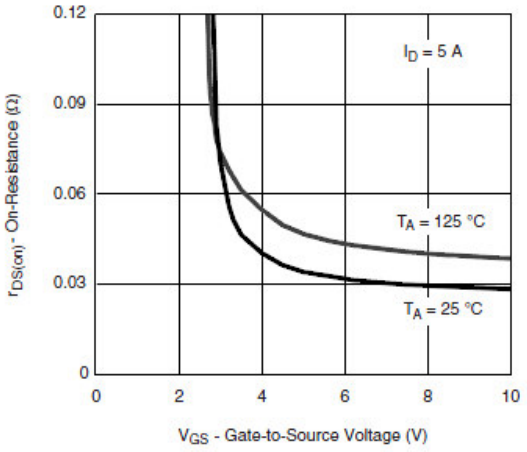


On-Resistance vs. Junction Temperature

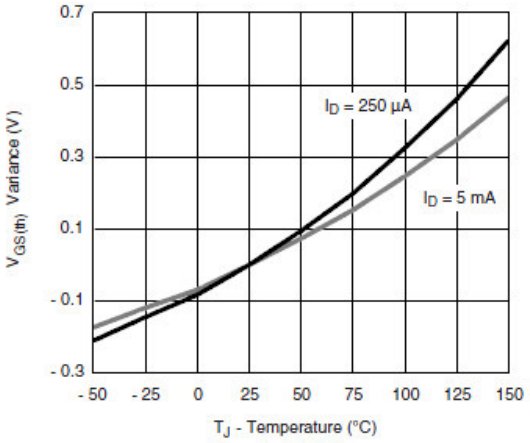
Typical Performance Characteristics (continue)



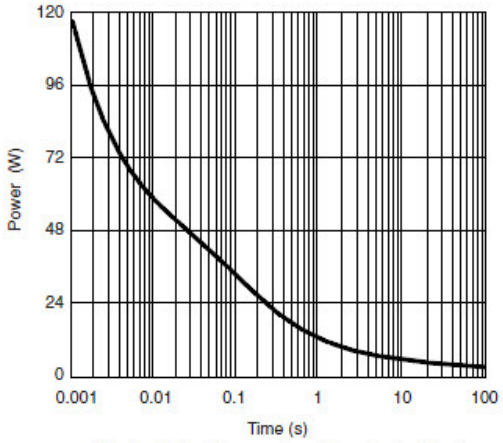
Source-Drain Diode Forward Voltage



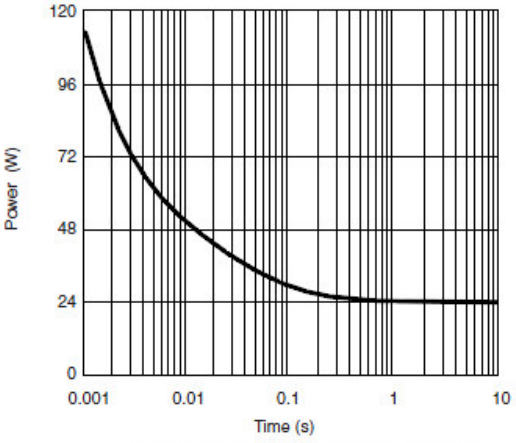
On-Resistance vs. Gate-to-Source Voltage



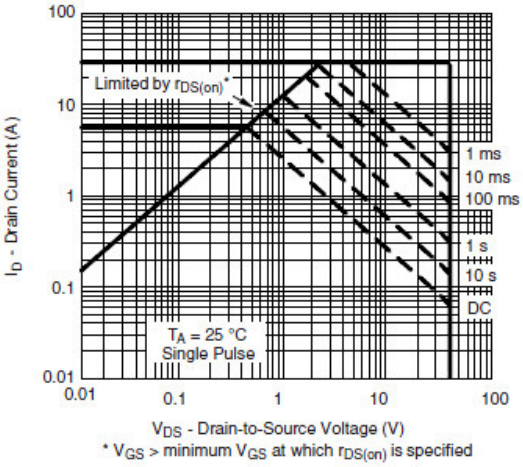
Threshold Voltage



Single Pulse Power, Junction-to-Ambient



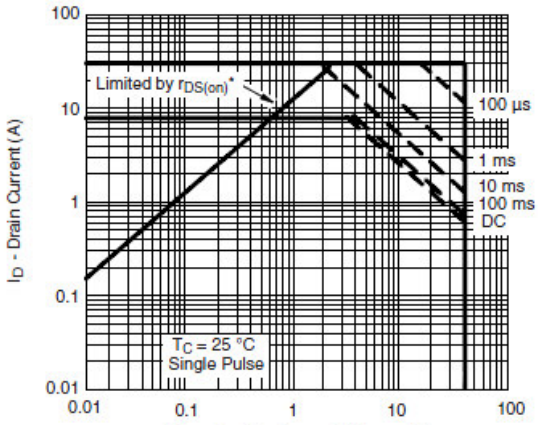
Single Pulse Power, Junction-to-Case



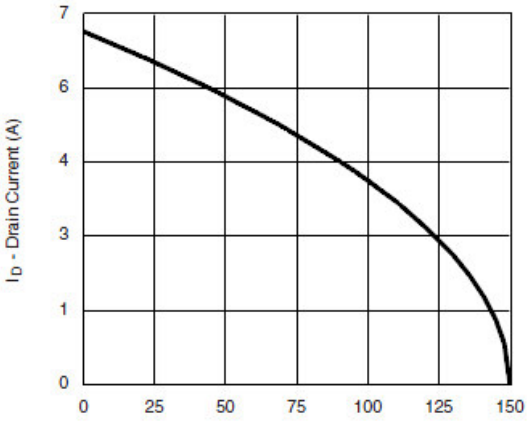
* V_{GS} > minimum V_{GS} at which $r_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

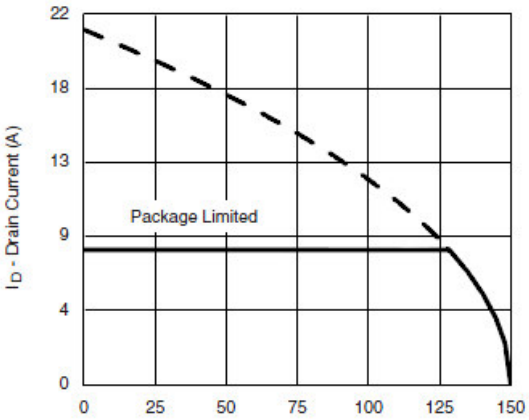
Typical Performance Characteristics (continue)



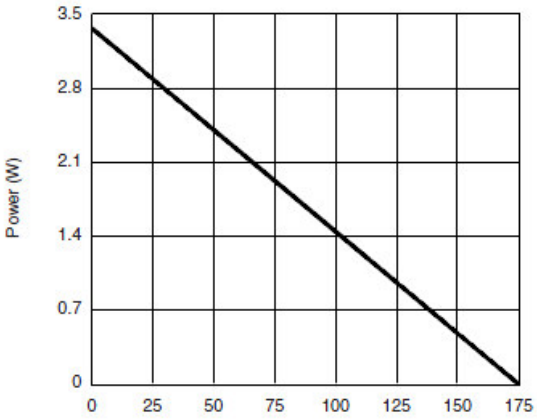
Safe Operating Area, Junction-to-Case



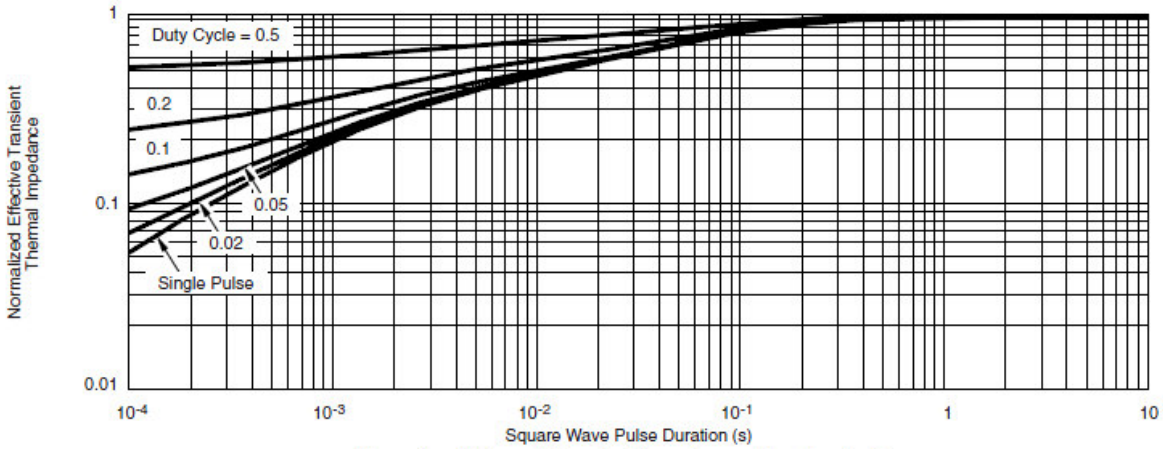
Current Derating*, Junction-to-Ambient



Current Derating*, Junction-to-Case



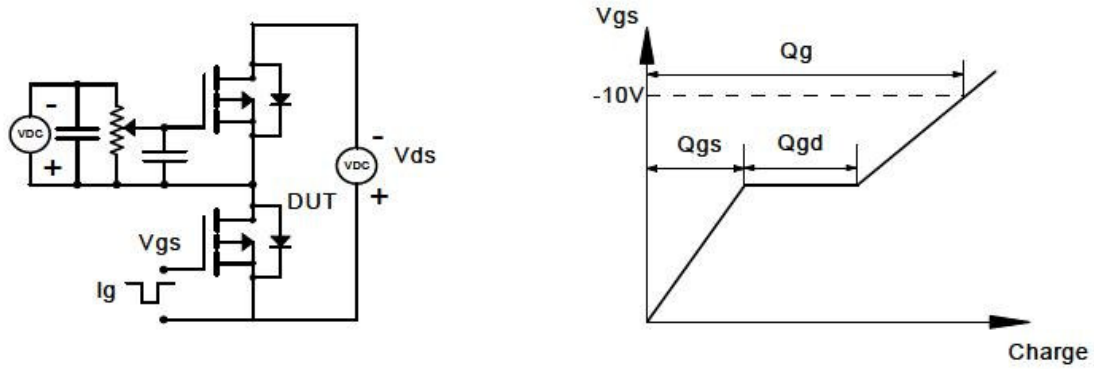
Power Derating*, Junction-to-Ambient



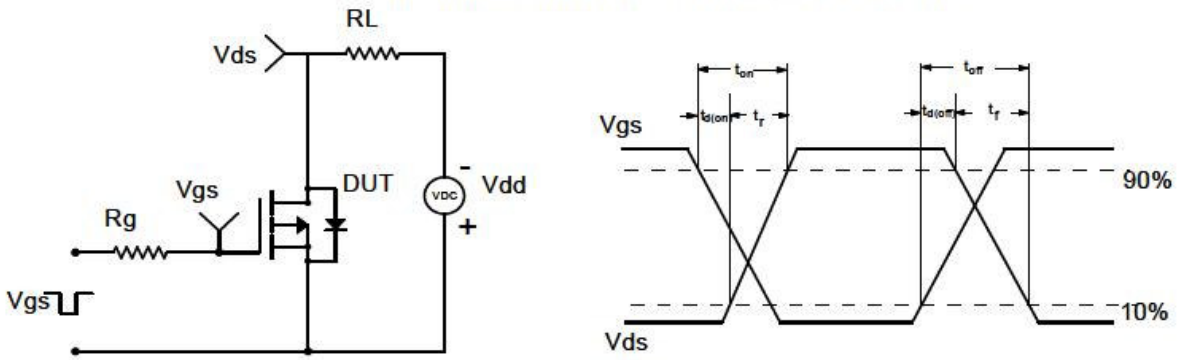
Normalized Thermal Transient Impedance, Junction-to-Case

Typical Characteristics

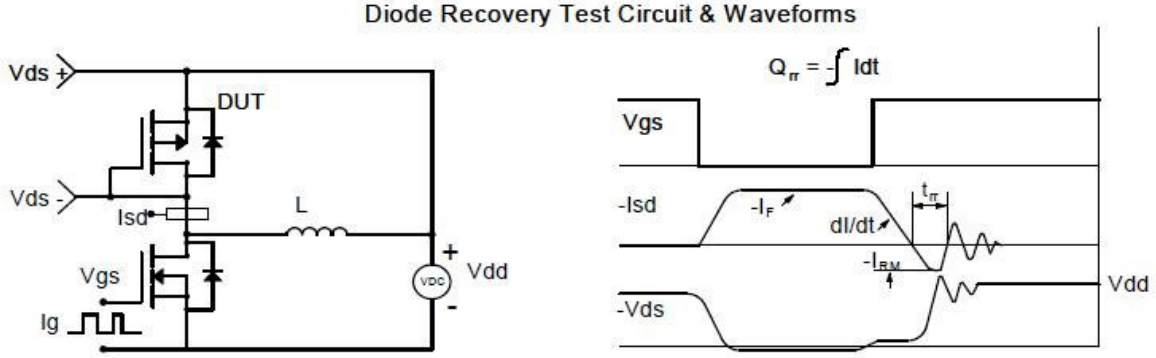
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

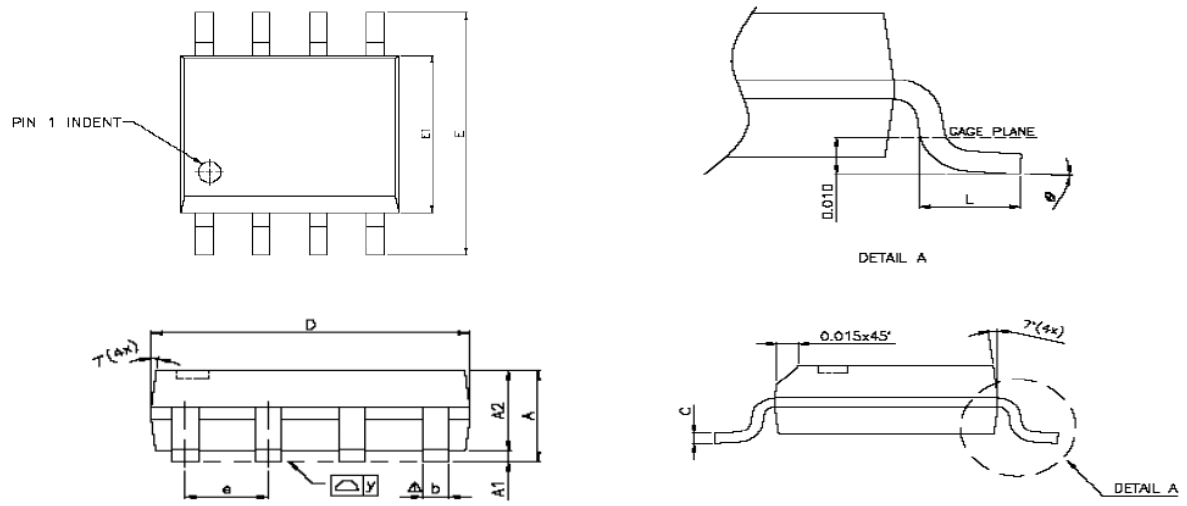


Diode Recovery Test Circuit & Waveforms



Package Dimension

SOP-8P PLASTIC PACKAGE



Dimensions						
SYMBOL	Millimeters			Inches		
	MIN	NOM	MAX	MIN	NOM	MAX
A	1.47	1.60	1.73	0.058	0.063	0.068
A1	0.10	-	0.25	0.004	-	0.010
A2	-	1.45	-	-	0.057	-
b	0.33	0.41	0.51	0.013	0.016	0.020
C	0.19	0.20	0.25	0.0075	0.008	0.0098
D	4.80	4.85	4.95	0.189	0.191	0.195
E	5.80	6.00	6.20	0.228	0.236	0.244
E1	3.80	3.90	4.00	0.150	0.154	0.157
e	-	1.27	-	-	0.050	-
L	0.38	0.71	1.27	0.015	0.028	0.050
②y	-	-	0.076	-	-	0.003
θ	0°	-	8°	0°	-	8°

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